

SILICON PLANAR EPITAXIAL TRANSISTORS

P-N-P transistors, in a microminiature plastic package, intended for low level, low noise general purpose applications in thick and thin-film circuits.

QUICK REFERENCE DATA

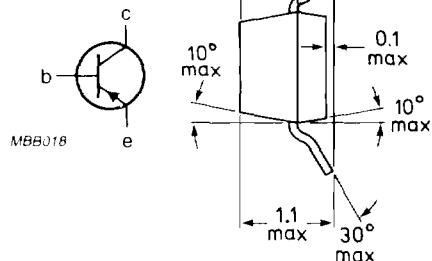
		BCF29	BCF30
D.C. current gain at $T_j = 25^\circ\text{C}$ $-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$	h_{FE}	$>$ 120 260	$<$ 215 500
Collector-base voltage (open emitter)	$-V_{CBO}$	max.	32
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	32
Collector current (peak value)	$-I_{CM}$	max.	200
Total power dissipation up to $T_{amb} = 25^\circ\text{C}$	P_{tot}	max.	250
Junction temperature	T_j	max.	150
Transition frequency at $f = 100 \text{ MHz}$ $-I_C = 10 \text{ mA}; -V_{CE} = 5 \text{ V}$	f_T	$>$	100
Noise figure at $R_S = 2 \text{ k}\Omega$ $-I_C = 200 \mu\text{A}; -V_{CE} = 5 \text{ V};$ $f = 1 \text{ kHz}; B = 200 \text{ Hz}$	F	$<$	4
			dB

MECHANICAL DATA

Fig. 1 SOT-23.

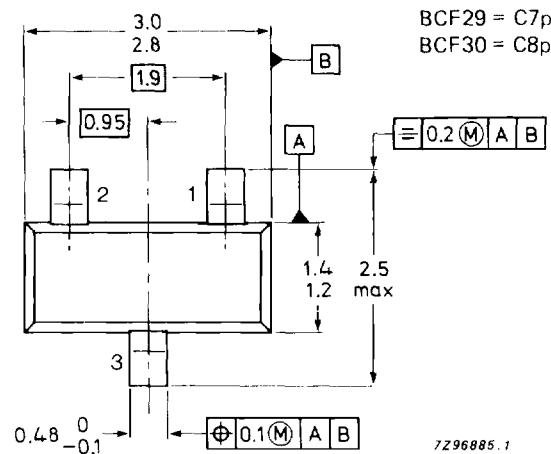
Pinning:

- 1 = base
- 2 = emitter
- 3 = collector



Reverse pinning types are available on request.

Dimensions in mm



TOP VIEW

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	32 V
Collector-emitter voltage ($V_{BE} = 0$)	$-V_{CES}$	max.	32 V
Collector-emitter voltage (open base) $-I_C = 2 \text{ mA}$	$-V_{CEO}$	max.	32 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	100 mA
Collector current (peak value)	$-I_{CM}$	max.	200 mA
Total power dissipation up to $T_{amb} = 25^\circ\text{C}^*$	P_{tot}	max.	250 mW
Storage temperature	T_{stg}		-65 to + 150 °C
Junction temperature	T_j	max.	150 °C

THERMAL RESISTANCE

From junction to ambient*	$R_{th \ j-a}$	=	500 K/W
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CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise specified

Collector cut-off current

 $I_E = 0; -V_{CB} = 32 \text{ V}$ $-I_{CBO}$ < 100 nA $I_E = 0; -V_{CB} = 32 \text{ V}; T_j = 100^\circ\text{C}$ $-I_{CBO}$ < 10 μA

Base-emitter voltage

 $-I_C = 2 \text{ mA}; -V_{CE} = 5 \text{ V}$ $-V_{BE}$ 600 to 750 mV

Saturation voltages

 $-I_C = 10 \text{ mA}; -I_B = 0,5 \text{ mA}$ $-V_{CEsat}$ typ. 80 mV

< 300 mV

 $-V_{BESat}$ typ. 720 mV $-V_{CEsat}$ typ. 150 mV $-V_{BESat}$ typ. 810 mV

* Mounted on an FR4 printed-circuit board 8 mm x 10 mm x 0.7 mm.

D.C. current gain			BCF29	BCF30
$-I_C = 10 \mu A; -V_{CE} = 5 V$	h_{FE}	typ.	90	150
$-I_C = 2 mA; -V_{CE} = 5 V$	h_{FE}	>	120	215
		<	260	500
Collector capacitance at $f = 1 MHz$ $I_E = I_e = 0; -V_{CB} = 10 V$	C_C	typ.	4,5	pF
Transition frequency at $f = 100 MHz$ $-I_C = 10 mA; -V_{CE} = 5 V$	f_T	>	100	MHz
Noise figure at $R_S = 2 k\Omega$ $-I_C = 200 \mu A; -V_{CE} = 5 V$ $f = 1 kHz; B = 200 Hz$	F	< typ.	4 1	dB dB